

Search Notes

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Junghwa M. Im

Applicant(s)/Patent under
Reexamination

SHEN ET AL.

Art Unit

2811

SEARCHED

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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (uspat, uspub, epo, jpo, der, ibm)	1/26/2006	JMI
text search: see search history printout	1/26/2006	JMI